## **CLAIMS**

## What is claimed is:

- An apparatus for spectral interferometry, said apparatus comprising an
  interferometer comprising a light source and an element dithered to provide a continuous
  relative phase shift between target and reference arms of the interferometer.
  - 2. The apparatus of claim 1 wherein said light source is mode locked.
- 3. The apparatus of claim 1 additionally comprising means for subtracting spectra that differ by said phase shift to create a differential spectral interferogram.
- 4. The apparatus of claim 3 additionally comprising means for performing a Fourier transform of said differential spectral interferogram, whereby an amplitude of a signal of interest is improved by a factor of approximately two as compared to non-differential spectral interferometry.
- 5. The apparatus of claim 1 additionally comprising means for determining both real and imaginary components of a complex interferogram.
- 6. The apparatus of claim 5 wherein said means for determining substantially removes 1/f noise.
  - 7. The apparatus of claim 1 wherein said element comprises a piezo translator.
- 8. The apparatus of claim 1 additionally comprising a detector providing lock-in detection for each of one or more pixels.
  - 9. The apparatus of claim 1 wherein said phase shift is approximately  $\pi$ .

- 10. The apparatus of claim 1 wherein said apparatus substantially rejects 1/f noise.
- 11. The apparatus of claim 1 wherein said apparatus substantially rejects low frequency noise.
- 12. The apparatus of claim 1 wherein said apparatus substantially reduces detection bandwidth.
- 13. The apparatus of claim 1 wherein said apparatus employs synchronous detection.
- 14. The apparatus of claim 13 wherein said synchronous detection comprises lock-in detection.
  - 15. An apparatus for spectral interferometry, said apparatus comprising:

an interferometer comprising a light source and an element dithered to provide a continuous relative phase shift between target and reference arms of the interferometer; and

a detector providing synchronous detection for each of one or more pixels.

- 16. An apparatus for spectral interferometry, said apparatus comprising:

  an interferometer comprising a light source and an element providing a relative phase shift between target and reference arms of the interferometer; and

  a detector providing synchronous detection for each of one or more pixels.
- 17. A method for spectral interferometry, the method comprising the steps of:

  providing an interferometer comprising a light source; and

  dithering an element to provide a continuous relative phase shift between target and reference arms of the interferometer.
  - 18. The method of claim 17 wherein the light source is mode locked.
- 19. The method of claim 17 additionally comprising the step of subtracting spectra that differ by the phase shift to create a differential spectral interferogram.
- 20. The method of claim 19 additionally comprising the step of performing a Fourier transform of the differential spectral interferogram, whereby an amplitude of a signal of interest is improved by a factor of approximately two as compared to non-differential spectral interferometry.
- 21. The method of claim 17 additionally comprising the step of determining both real and imaginary components of a complex interferogram.
- 22. The method of claim 21 wherein the determining step substantially removes 1/f noise.
  - 23. The method of claim 17 wherein the element comprises a piezo translator.

- 24. The method of claim 17 additionally comprising the step of providing lock-in detection for each of one or more pixels of a detector.
  - 25. The method of claim 17 wherein the phase shift is approximately  $\pi$ .
  - 26. The method of claim 17 wherein the method substantially rejects 1/f noise.
- 27. The method of claim 17 wherein the method substantially rejects low frequency noise.
- 28. The method of claim 17 wherein the method substantially reduces detection bandwidth.
- 29. The method of claim 17 additionally comprising the step of employing synchronous detection.
- 30. The method of claim 29 wherein the employing step comprises employing lock-in detection.
- 31. A method for spectral interferometry, the method comprising the steps of:

  providing an interferometer comprising a light source;

  dithering an element to provide a continuous relative phase shift between target and reference arms of the interferometer; and

providing lock-in detection for each of one or more pixels of a detector.

32. A method for spectral interferometry, the method comprising the steps of:

providing an interferometer comprising a light source;

employing an element to provide a relative phase shift between target and reference arms of the interferometer; and

providing lock-in detection for each of one or more pixels of a detector.